

An Ultra-Low Noise Cryogenic Ka-Band InGaAs/InAlAs/InP HEMT Front-End Receiver

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We present here the design and performance of a 4-stage Ka-band cryogenic amplifier using a front-end 0.1 μ m gate length InP HEMT. The amplifier demonstrated 20-25 K uncorrected noise temperature (\sim 0.3-dB noise figure) from 31-33 GHz with 30-33 dB associated gain at 12 K ambient temperature. To date, this is the best reported HEMT cryogenic amplifier performance at this frequency band and is a factor of two improvement in noise temperature compared to previous designs.

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